Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/040,466	TANABE ET AL.
Examiner	Art Unit
DANG T. TON	2666

SEARCHED				
Class	Subclass	Date	Examiner	
updated		9/26/05	10	

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	

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